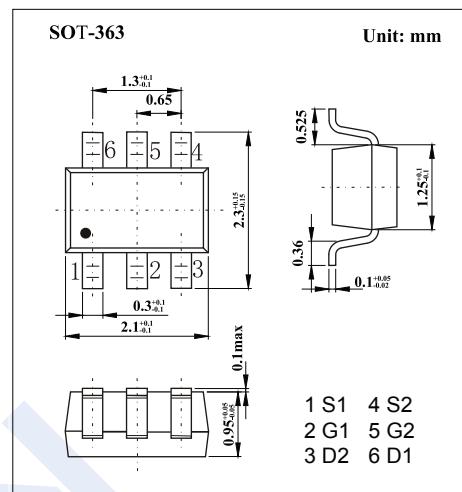
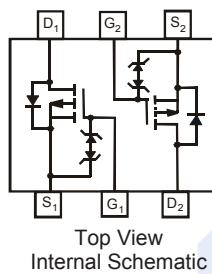


Dual P-channel MOSFET

2KJ6051

■ Features

- $BV_{DSS} = -20\text{ V}$
- $I_D = -0.9\text{ A} @ V_{GS} = -4.5\text{ V}$
- $R_{DS(ON)} < 520\text{ m}\Omega @ V_{GS} = -4.5\text{ V}$
- $R_{DS(ON)} < 700\text{ m}\Omega @ V_{GS} = -2.5\text{ V}$
- $R_{DS(ON)} < 950\text{ m}\Omega @ V_{GS} = -1.8\text{ V}$
- ESD Protected Gate



■ Absolute Maximum Ratings ($TA = 25^\circ\text{C}$ unless otherwise stated)

Parameter	Symbol	Rating	Unit
Drain-Source Voltage	V_{DS}	-20	V
Gate-Source Voltage	V_{GS}	± 8	
Continuous Drain Current (Note 1)	I_D	-0.6	A
		-0.48	
Pulsed Drain Current (Note 2)	I_{DM}	-3	$^\circ\text{C}/\text{W}$
Thermal Resistance, Junction- to-Ambient (Note 1)	R_{JA}	460	
Thermal Resistance, Junction- to-Lead (Note 3)	R_{JL}	350	
Power Dissipation (Note 1)	P_D	0.3	W
		0.19	
Junction Temperature	T_J	150	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	-55 to 150	

Notes:

1. The value of R_{JA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with $TA = 25^\circ\text{C}$. The value in any given application depends on the user's specific board design. The current rating is based on the $t \leq 10\text{s}$ thermal resistance rating.
2. Repetitive rating, pulse width limited by junction temperature.
3. The R_{JA} is the sum of the thermal impedance from junction to lead R_{JL} and lead to ambient.

Dual P-channel MOSFET

2KJ6051

■ Electrical Characteristics ($T_J = 25^\circ\text{C}$ unless otherwise specified)

Parameter	Symbol	Test Conditions	Min	Typ	Max	Unit
OFF Characteristics						
Drain-Source Breakdown Voltage	BV_{DSS}	$\text{Id} = -250 \mu\text{A}, \text{V}_{\text{GS}} = 0\text{V}$	-20			V
Zero Gate Voltage Drain Current	I_{DSS}	$\text{V}_{\text{DS}} = -16 \text{ V}, \text{V}_{\text{GS}} = 0 \text{ V}$			-1	μA
		$\text{V}_{\text{DS}} = -16 \text{ V}, \text{V}_{\text{GS}} = 0 \text{ V}, T_J = 55^\circ\text{C}$			-5	
Gate to Source Leakage Current	I_{GSS}	$\text{V}_{\text{DS}} = 0 \text{ V}, \text{V}_{\text{GS}} = \pm 8 \text{ V}$			± 10	
ON Characteristics						
Gate to Source Threshold Voltage	$\text{V}_{\text{GS(th)}}$	$\text{V}_{\text{DS}} = \text{V}_{\text{GS}}, \text{Id} = -250 \mu\text{A}$	-0.5		-0.9	V
Static Drain-Source On-Resistance	$\text{R}_{\text{DS(on)}}$	$\text{V}_{\text{GS}} = -4.5 \text{ V}, \text{Id} = -0.6 \text{ A}$			520	$\text{m}\Omega$
		$\text{V}_{\text{GS}} = -4.5 \text{ V}, \text{Id} = -0.6 \text{ A}, T_J = 125^\circ\text{C}$			700	
		$\text{V}_{\text{GS}} = -2.5 \text{ V}, \text{Id} = -0.5 \text{ A}$			700	
		$\text{V}_{\text{GS}} = -1.8 \text{ V}, \text{Id} = -0.4 \text{ A}$			950	
Forward Transconductance	g_{FS}	$\text{V}_{\text{DS}} = -5 \text{ V}, \text{Id} = -0.6 \text{ A}$		1.7		S
Charges and Capacitances						
Input Capacitance	C_{iss}	$\text{V}_{\text{GS}} = 0 \text{ V}, \text{V}_{\text{DS}} = -10 \text{ V}, f = 1 \text{ MHz}$		114	140	pF
Output Capacitance	C_{oss}			17		
Reverse Transfer Capacitance	C_{rss}			14		
Gate resistance	R_g	$\text{V}_{\text{GS}} = 0 \text{ V}, \text{V}_{\text{DS}} = 0 \text{ V}, f = 1 \text{ MHz}$		12	17	Ω
Total Gate Charge	Q_g	$\text{V}_{\text{GS}} = -4.5 \text{ V}, \text{V}_{\text{DS}} = -10 \text{ V}, \text{Id} = -0.6 \text{ A}$		1.44	1.8	nC
Gate Source Charge	Q_{gs}			0.14		
Gate Drain Charge	Q_{gd}			0.35		
Switching Characteristics						
Turn-On Delay Time	$\text{t}_{\text{d(on)}}$	$\text{V}_{\text{GS}} = -4.5 \text{ V}, \text{V}_{\text{DS}} = -10 \text{ V}, \text{RL} = 16.7 \Omega, \text{R}_{\text{GEN}} = 3 \Omega$		6.5		ns
Turn-On Rise Time	t_r			6.5		
Turn-Off Delay Time	$\text{t}_{\text{d(off)}}$			18.2		
Turn-Off Fall Time	t_f			5.5		
Drain-Source Diode Characteristics						
Reverse Recovery Time	t_{rr}	$\text{I}_{\text{F}} = -0.6 \text{ A}, \text{di/dt} = 100 \text{ A}/\mu\text{s}$		10	13	ns
Reverse Recovery Charge	Q_{rr}			3		nC
Diode Forward Voltage	V_{SD}	$\text{V}_{\text{GS}} = 0 \text{ V}, \text{I}_{\text{S}} = -0.5 \text{ A}$		-0.86	-1	V
Maximum Continuous Current	I_{S}				-0.4	A

Notes:

4. The static characteristics in Figures 1 to 6 are obtained using $80 \mu\text{s}$ pulses, duty cycle 0.5% max.
5. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $\text{TA}=25^\circ\text{C}$. The SOA curve provides a single pulse rating.

■ Marking

Marking	JBZ
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Dual P-channel MOSFET

2KJ6051

■ Typical Electrical and Thermal Characteristics

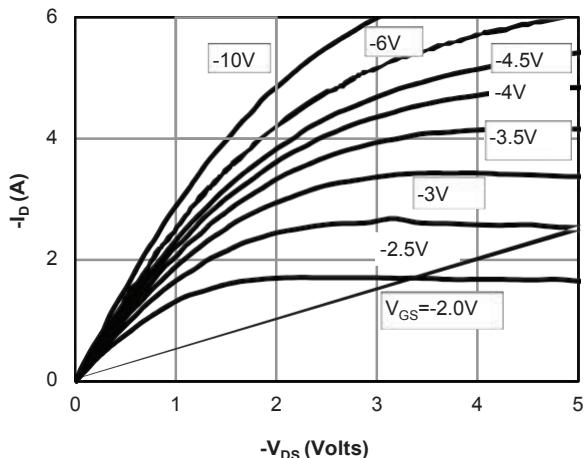


Fig 1: On-Region Characteristics

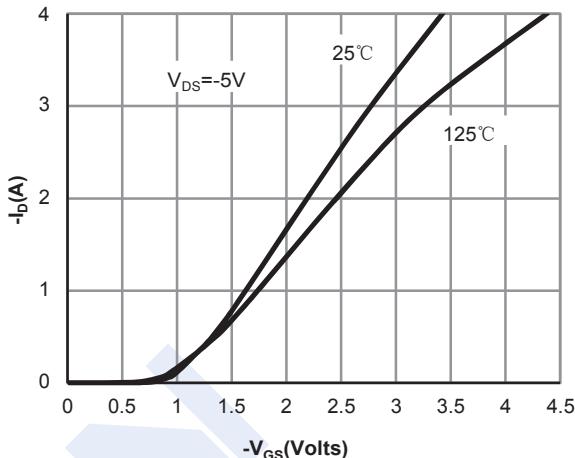


Figure 2: Transfer Characteristics

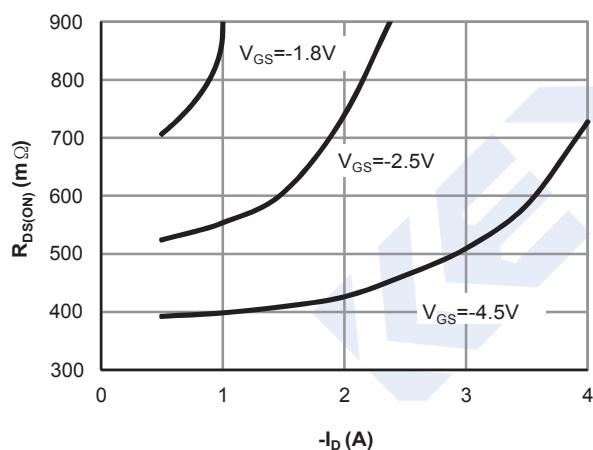


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

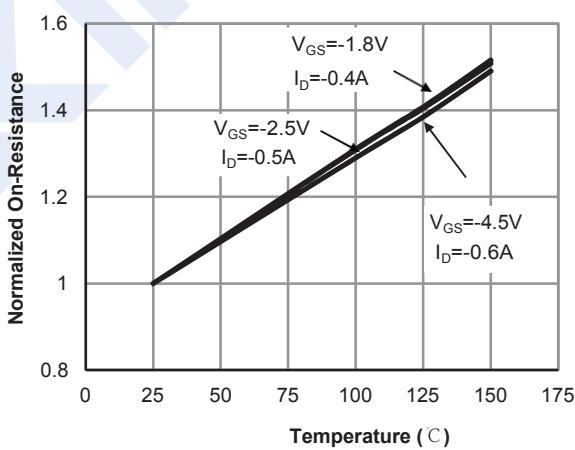


Figure 4: On-Resistance vs. Junction Temperature

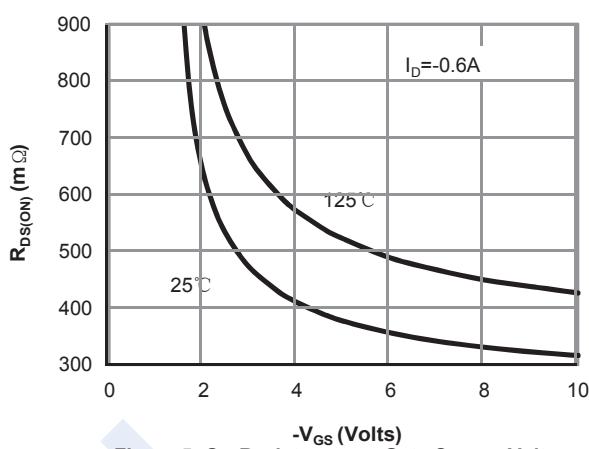


Figure 5: On-Resistance vs. Gate-Source Voltage

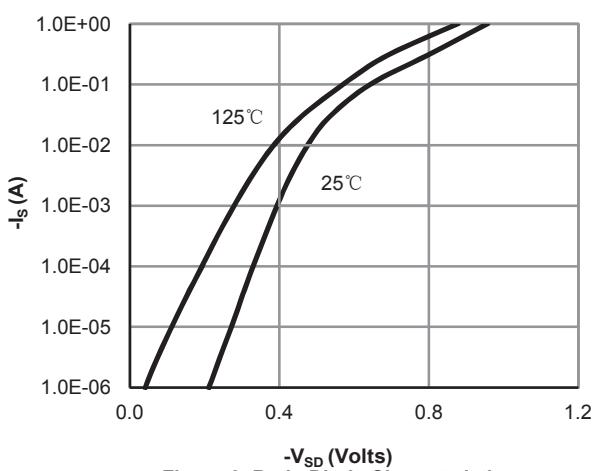


Figure 6: Body-Diode Characteristics

Dual P-channel MOSFET

2KJ6051

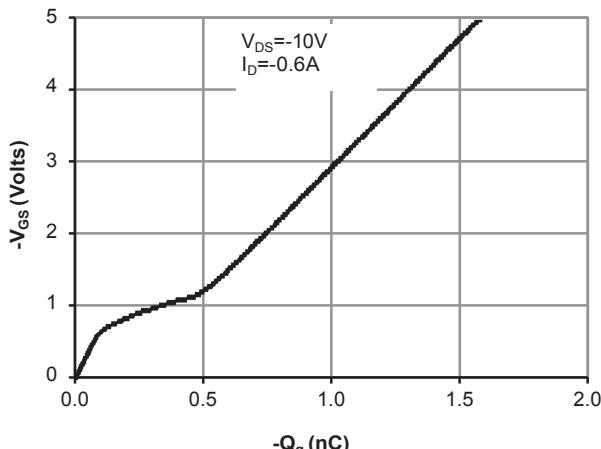


Figure 7: Gate-Charge Characteristics

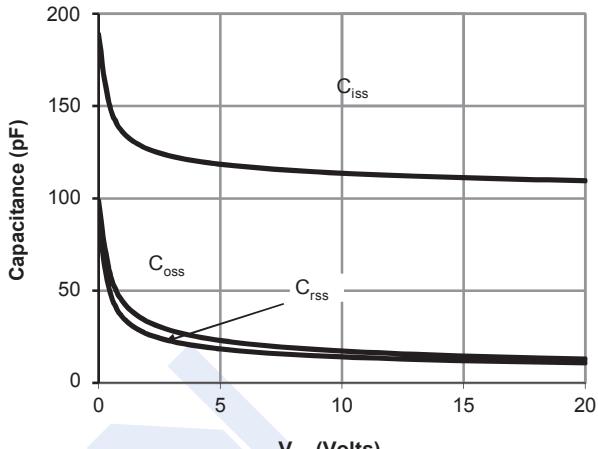


Figure 8: Capacitance Characteristics

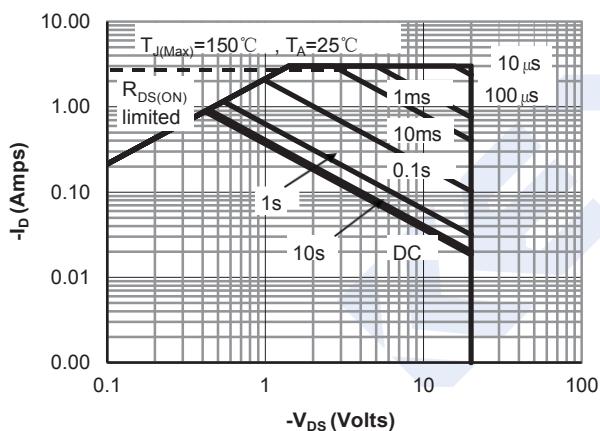


Figure 9: Maximum Forward Biased Safe Operating Area (Note 5)

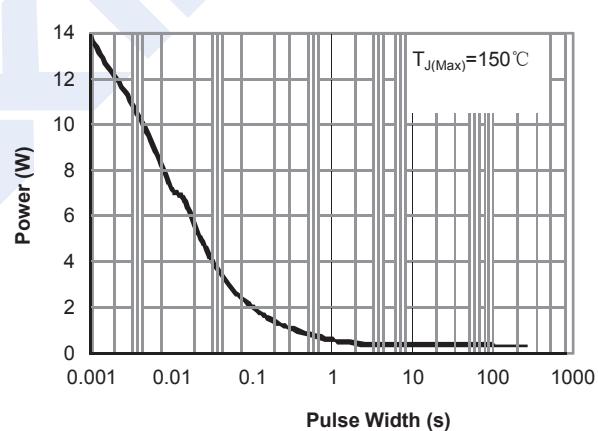


Figure 10: Single Pulse Power Rating Junction-to-Ambient (Note 5)

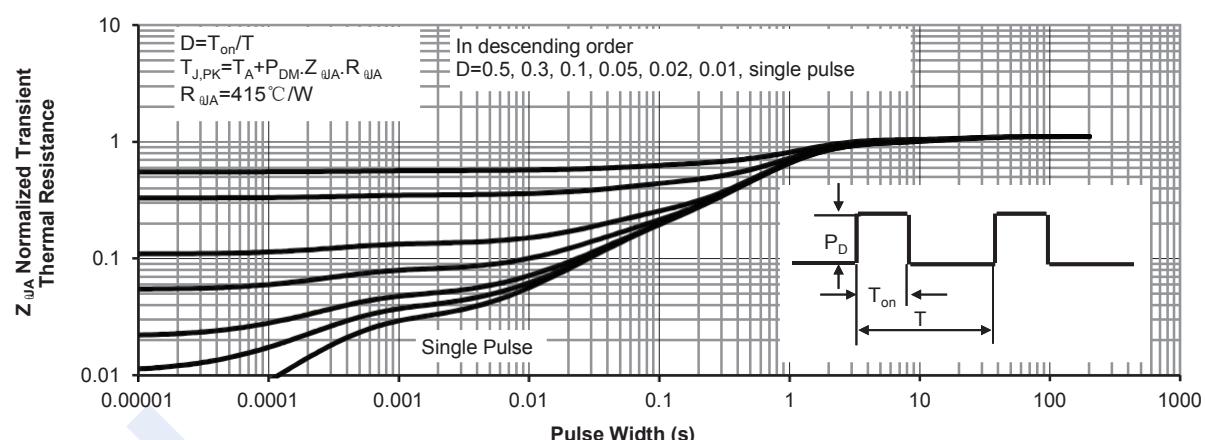


Figure 11: Normalized Maximum Transient Thermal Impedance